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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/550,183	06/06/2006	Bryan E. Cole	M0025.0339/P339	5251
24998	7590	10/29/2008	EXAMINER	
DICKSTEIN SHAPIRO LLP			TANINGCO, MARCUS H	
1825 EYE STREET NW				
Washington, DC 20006-5403			ART UNIT	PAPER NUMBER
			2884	
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			10/29/2008	PAPER

Please find below and/or attached an Office communication concerning this application or proceeding.

The time period for reply, if any, is set in the attached communication.

Office Action Summary	Application No.	Applicant(s)	
	10/550,183	COLE ET AL.	
	Examiner	Art Unit	
	MARCUS H. TANINGCO	2884	

-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --

Period for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) OR THIRTY (30) DAYS, WHICHEVER IS LONGER, FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

Status

- 1) Responsive to communication(s) filed on 15 October 2008.
 2a) This action is **FINAL**. 2b) This action is non-final.
 3) Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

Disposition of Claims

- 4) Claim(s) 1-5 and 30-44 is/are pending in the application.
 4a) Of the above claim(s) _____ is/are withdrawn from consideration.
 5) Claim(s) _____ is/are allowed.
 6) Claim(s) 1-5 and 30-44 is/are rejected.
 7) Claim(s) _____ is/are objected to.
 8) Claim(s) _____ are subject to restriction and/or election requirement.

Application Papers

- 9) The specification is objected to by the Examiner.
 10) The drawing(s) filed on 21 September 2005 is/are: a) accepted or b) objected to by the Examiner.
 Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).
 Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).
 11) The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.

Priority under 35 U.S.C. § 119

- 12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
 a) All b) Some * c) None of:
 1. Certified copies of the priority documents have been received.
 2. Certified copies of the priority documents have been received in Application No. _____.
 3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).

* See the attached detailed Office action for a list of the certified copies not received.

Attachment(s)

- | | |
|--|---|
| 1) <input checked="" type="checkbox"/> Notice of References Cited (PTO-892) | 4) <input type="checkbox"/> Interview Summary (PTO-413) |
| 2) <input type="checkbox"/> Notice of Draftsperson's Patent Drawing Review (PTO-948) | Paper No(s)/Mail Date. _____ . |
| 3) <input type="checkbox"/> Information Disclosure Statement(s) (PTO/SB/08) | 5) <input type="checkbox"/> Notice of Informal Patent Application |
| Paper No(s)/Mail Date _____. | 6) <input type="checkbox"/> Other: _____ . |

DETAILED ACTION

Continued Examination Under 37 CFR 1.114

A request for continued examination under 37 CFR 1.114, including the fee set forth in 37 CFR 1.17(e), was filed in this application after final rejection. Since this application is eligible for continued examination under 37 CFR 1.114, and the fee set forth in 37 CFR 1.17(e) has been timely paid, the finality of the previous Office action has been withdrawn pursuant to 37 CFR 1.114. Applicant's submission filed on 9/5/2008 has been entered.

Response to Arguments

Applicant's arguments with respect to claims 1, 2, 42, and 43 have been considered but are moot in view of the new ground(s) of rejection.

Claim Rejections - 35 USC § 112

The following is a quotation of the second paragraph of 35 U.S.C. 112:

The specification shall conclude with one or more claims particularly pointing out and distinctly claiming the subject matter which the applicant regards as his invention.

Claims 1-5 and 30-44 are rejected under 35 U.S.C. 112, second paragraph, as being indefinite for failing to particularly point out and distinctly claim the subject matter which applicant regards as the invention.

Claims 1, 2, 42, and 43 recites the limitation "the surrounding material". There is insufficient antecedent basis for this limitation in the claim.

Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negated by the manner in which the invention was made.

This application currently names joint inventors. In considering patentability of the claims under 35 U.S.C. 103(a), the examiner presumes that the subject matter of the various claims was commonly owned at the time any inventions covered therein were made absent any evidence to the contrary. Applicant is advised of the obligation under 37 CFR 1.56 to point out the inventor and invention dates of each claim that was not commonly owned at the time a later invention was made in order for the examiner to consider the applicability of 35 U.S.C. 103(c) and potential 35 U.S.C. 102(e), (f) or (g) prior art under 35 U.S.C. 103(a).

Claims 1-4, 34, 38, 39, and 41-43 rejected under 35 U.S.C. 103(a) as being unpatentable over Nuss (US 5,623,145) in view of Wallace et al. (*Wallace*, US 2005/0082479).

With regards to claims 1, 3, 42, and 43, Nuss discloses a method and apparatus for THZ imaging wherein: an optical source generates pulsed radiation in the range of 100 Ghz to 20 Thz at an object; and a detector detects signals after propagation through said object, wherein said signals are analyzed to determine the composition of said object (column 2, lines 15-55); and wherein said apparatus is also capable of differentiating between different materials (*surrounding material*) in the object (Abstract). The method and apparatus, as disclosed by Nuss, has applications in materials inspection and packaging inspection, but lacks a specific description for use in detecting explosive materials. Nevertheless, both Nuss and the claimed

invention teach methods of identifying material composition using Thz imaging techniques. As such, it would have been obvious to one with ordinary skill in the art at the time the invention was made to modify Nuss since the substitution of one known element for another would have yielded predictable results. Although Nuss fails to teach adjusting the detected radiation signal to compensate for the effect of surrounding material, Wallace teaches a Thz imaging method and apparatus wherein a baseline signal is subtracted from a detected signal in order to compensate for a surrounding material [0033-0034]. Thus, it would have been obvious to one of ordinary skill in the art to apply the technique of identifying target materials by compensating for a surrounding material for the predictable result of differentiating between different materials.

With regards to claim 2, Nuss discloses a method and apparatus for THZ imaging wherein: an optical source generates pulsed radiation in the range of 100 Ghz to 20 Thz at an object; and a detector detects signals after propagation through said object, wherein said signals are analyzed to determine the composition of said object (column 2, lines 15-55); and wherein said apparatus is also capable of differentiating between different materials (*surrounding material*) in the object (Abstract). The method and apparatus, as disclosed by Nuss, has applications in materials inspection and packaging inspection, but lacks a specific description for use in detecting explosive materials. Nevertheless, both Nuss and the claimed invention teach methods of identifying material composition using Thz imaging techniques. As such, it would have been obvious to one with ordinary skill in the art at the time the invention was made to modify Nuss since the substitution of one known element for another would have yielded predictable results. Although Nuss fails to teach a continuous source, those skilled in the art appreciate that either pulsed laser or multiple continuous wave sources may be used and are

considered art recognized equivalents and considered a matter of routine design choice. Although Nuss fails to teach adjusting the detected radiation signal to compensate for the effect of surrounding material, Wallace teaches a Thz imaging method and apparatus wherein a baseline signal is subtracted from a detected signal in order to compensate for a surrounding material [0033-0034]. Thus, it would have been obvious to one of ordinary skill in the art to apply the technique of identifying target materials by compensating for a surrounding material for the predictable result of differentiating between different materials.

With regards to claims 34, 38 and 39, Nuss discloses a method and apparatus for THZ imaging with applications in materials inspection and packaging inspection (column 2, lines 31-47), but fails to teach compensating for the member covering the object of interest by differentiating the detected radiation by obtaining the first derivative of a frequency spectrum of the detected radiation. Nevertheless, those skilled in the art appreciate that compensating for attenuation would have been obvious since the technique for improving a particular class of devices was part of the ordinary capabilities of a person of ordinary skill in the art (*KSR International Co. v. Teleflex Inc.*, 550 U.S.-, 82 USPQ2d 1385 (2007)).

With regards to claim 4, Nuss discloses analyzing the detected radiation by determining a frequency spectrum from the detected radiation since certain material and objects can be characterized by a frequency-dependent absorption, dispersion, and reflection of terahertz transients in signals which pass through the material or object (column 2, lines 30-34).

With regards to claim 41, Nuss fails to specifically teach determining whether a reference beam is in phase with the detected radiation and adjusting the detected radiation. Those skilled in the art appreciate that in order to derive sensible information from a sample, there is a need to

measure the change in the phase of the source beam caused by the sample. Thus, detector 2 needs to know some information about the phase of the radiation leaving the source. A way of doing this is to use a reference beam, which has a phase related to that of the source beam and which is received by the detector. Actually, many detectors of THz radiation require a reference beam in order to detect radiation received by the detector. As such, determining whether a reference beam is in phase with the detected radiation and adjusting the detected radiation is viewed as a matter of routine design choice.

Claims 5, 30-33, and 44 are rejected under 35 U.S.C. 103(a) as being unpatentable over Nuss in view of Wallace et al. (*Wallace*, US 2005/0082479) and Hartick et al. (*Hartick*, US 2001/0033636).

With regards to claims 5, 30, 31, and 44, Nuss lacks a description of obtaining a frequency spectrum at a number of predetermined frequencies. Hartick teaches a method of detecting explosives in luggage comprising: analyzing a frequency spectrum and comparing said spectrum to different explosives, wherein the measured energies can provide an indication of the presence of an explosive, and can thereby provide information about the presence and nature of an explosive material in the object [0005]. It would have been obvious to one with ordinary skill in the art at the time the invention was made to modify Nuss with the method taught by Hartick in order to detect explosives.

With regards to claims 32 and 33, Nuss discloses the claimed invention except for the calculation of intensity ratios. Nevertheless, manipulating the data received from the detected

radiation would have been within the skill of one with ordinary skill in the art at the time of the invention for various analysis techniques as is therefore seen as a matter of routine design choice.

Claims 35-37 are rejected under 35 U.S.C. 103(a) as being unpatentable over Nuss in view of Wallace et al. (*Wallace*, US 2005/0082479), Hartick et al. and Mickan et al. (*Mickan*, US 6,605,808).

With regards to claims 35 and 36, Nuss fails to teach a predetermined frequency corresponding to a region of low water absorption. Mickan teaches a diagnostic apparatus using Thz radiation. Mickan explains that Thz is strongly attenuated by the object under inspection because of water absorption (column 1, lines 54-57). Therefore, in order to effectively inspect an object under inspection, it would have been obvious to one with ordinary skill in the art at the time the invention was made to modify the method taught by Nuss to include analysis at a predetermined frequency corresponding to a region of low water absorption to reduce the effects of attenuation of the Thz rays.

With regards to claim 37, Nuss fails to teach reducing the resolution in the analysis of the detected radiation in order to reduce the effects of water absorption. Nevertheless, Mickan explains that Thz is strongly attenuated by the object under inspection because of water absorption (column 1, lines 54-57) and thus reducing the effects of water absorption would generally improve the conditions of the detected radiation. As such, reducing the resolution in the analysis of the detected radiation would have been obvious since the technique for improving a particular class of devices was part of the ordinary capabilities of a person of ordinary skill in

the art, in view of the teaching for improvement in other situations (*KSR International Co. v. Teleflex Inc.*, 550 U.S.-, 82 USPQ2d 1385 (2007)).

Claim 40 is rejected under 35 U.S.C. 103(a) as being unpatentable over Nuss in view of Wallace et al. (*Wallace*, US 2005/0082479) and Miller (US Reissue 36,201).

With regards to claim 40, Nuss discloses the claimed invention except for measuring the TOF of the detected radiation to determine whether the object is an explosive material from the absorption measure. Miller teaches a detector to identify explosives using TOF techniques to determine the composition of the material (column 15, lines 40-49; column 17, lines 36-64). Therefore, it would have been obvious to one with ordinary skill in the art at the time the invention was made to modify Nuss with a method including a TOF measurement in order to effectively identify explosive materials.

Conclusion

The prior art made of record and not relied upon is considered pertinent to applicant's disclosure.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Marcus H. Taningco whose telephone number is (571) 272-1848. The examiner can normally be reached on M - F 9:00 - 5:30.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Dave Porta can be reached on (571) 272-2444. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see <http://pair-direct.uspto.gov>. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

*/Marcus H Taningco/
Primary Examiner, Art Unit 2884*